Supporting information

Lead-free AgBiI₄ perovskite artificial synapses for tactile sensory

neuron system with information preprocessing function

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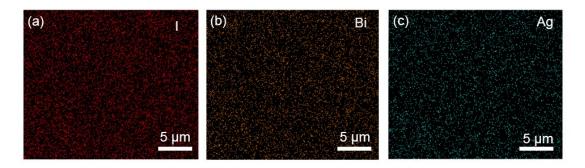


Fig. S1 The energy dispersive spectroscopy (EDS) elemental mapping of the $AgBiI_4$ components (Ag, Bi and I).

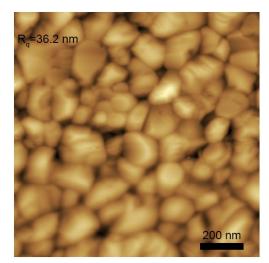


Fig. S2 The AFM measurement of the $AgBiI_4$ film.

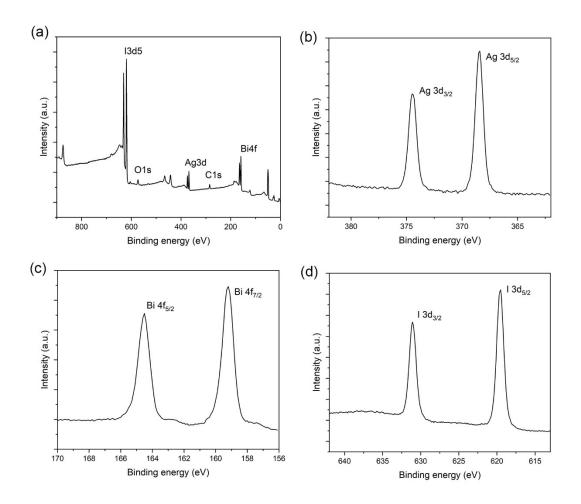


Fig. S3 The X-ray photoelectron spectroscopy (XPS) spectrum of the Ag, Bi and I element in the AgBiI₄ film.

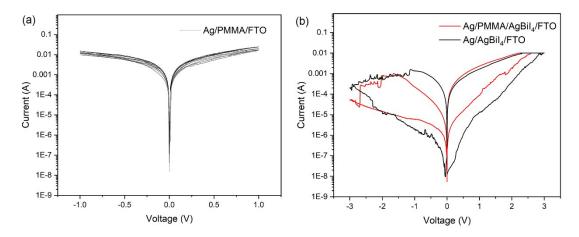


Fig. S4 (a) The I-V characteristics of the PMMA with a structure of ITO/PMMA/Ag. (b) The I-V characteristics of the $AgBiI_4$ devices with or without PMMA insulating layer.

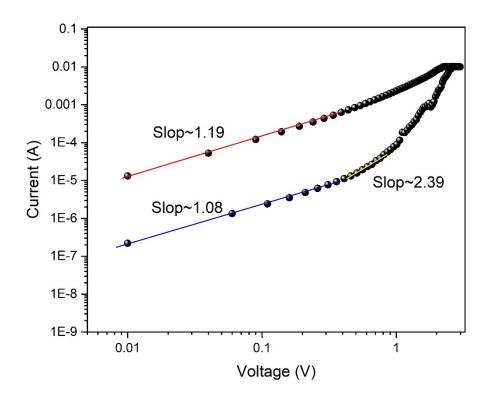


Fig. S5 The logarithmic I–V plots for the positive-voltage region of the AgBiI₄ device.

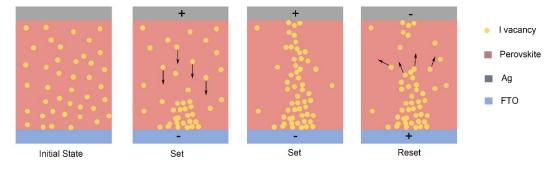


Fig. S6 Schematic illustration of the formation and disruption of the V_I conductive filaments.

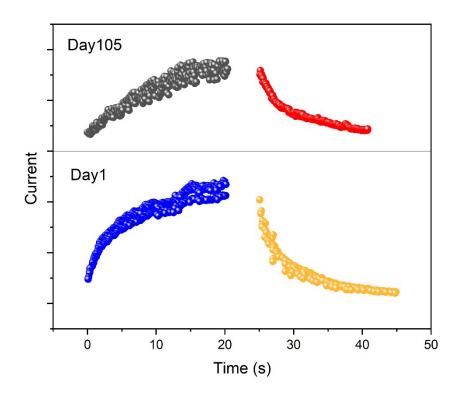


Fig. S7 the LTP and LTD characteristics of the device before and after storage.

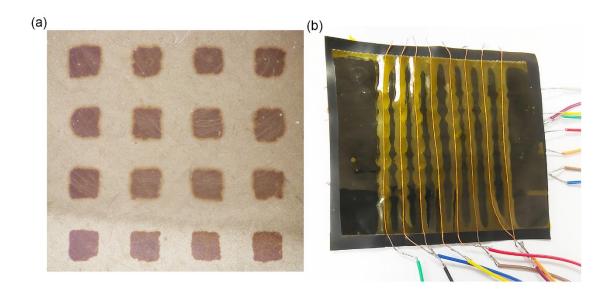


Fig. S8 The photographs of (a) the $AgBiI_4$ artificial synaptic device and (b) the tactile sensor.

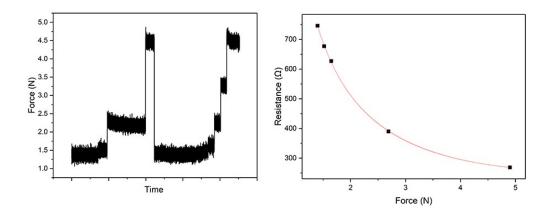


Fig. S9 The pressure response of the tactile sensor.

| Element | Atomic (%) | |
|---------|------------|--|
| Ag | 9.18 | |
| Bi | 9.44 | |
| Ι | 42.38 | |
| | | |

Table. S1 Element ratios of $AgBiI_4$ layer from XPS survey.